



High-end Power Semiconductor Manufacturer

KP3200A 3500V-4400V

Phase Control Thyristor

- High power cycling capability
- Low on-state and switching losses
- Designed for traction and industrial applications



Mean on-state current	I _{TAV}	3200 A		
Repetitive peak off-state voltage	V _{DRM}	3500 – 4400 V		
Repetitive peak reverse voltage	V _{RRM}			
Turn-off time	t _q	800 μs		
V _{DRM} , V _{RRM} , V	3500	4000	4200	4400
Voltage code	35	40	42	44
T _j , °C		– 60 – 125		

MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions
ON-STATE				
I _{TAV}	Mean on-state current	A	3200	T _c = 85 °C, Double side cooled 180° half-sine wave; 50 Hz
I _{TRMS}	RMS on-state current	A	5024	T _c = 85 °C, Double side cooled 180° half-sine wave; 50 Hz
I _{TSM}	Surge on-state current	kA	55.0 63.0	T _j =T _j max T _j =25 °C 180° half-sine wave; 50 Hz (t _p =10 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 μs; di _G /dt≥1 A/μs
			58.0 67.0	T _j =T _j max T _j =25 °C 180° half-sine wave; 60 Hz (t _p =8.3 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 μs; di _G /dt≥1 A/μs
I ² t	Safety factor	A ² s·10 ³	15125 19845	T _j =T _j max T _j =25 °C 180° half-sine wave; 50 Hz (t _p =10 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 μs; di _G /dt≥1 A/μs
			13960 18625	T _j =T _j max T _j =25 °C 180° half-sine wave; 60 Hz (t _p =8.3 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 μs; di _G /dt≥1 A/μs
BLOCKING				
V _{DRM} , V _{RRM}	Repetitive peak off-state and Repetitive peak reverse voltages	V	3500–4400	T _{j min} < T _j <T _{j max} ; 180° half-sine wave; 50 Hz; Gate open
V _{DSM} , V _{RSM}	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	3600–4500	T _{j min} < T _j <T _{j max} ; 180° half-sine wave; 50 Hz;single pulse; Gate open
V _D , V _R	Direct off-state and Direct reverse voltages	V	0.75·V _{DRM} 0.75·V _{RRM}	T _j =T _j max; Gate open

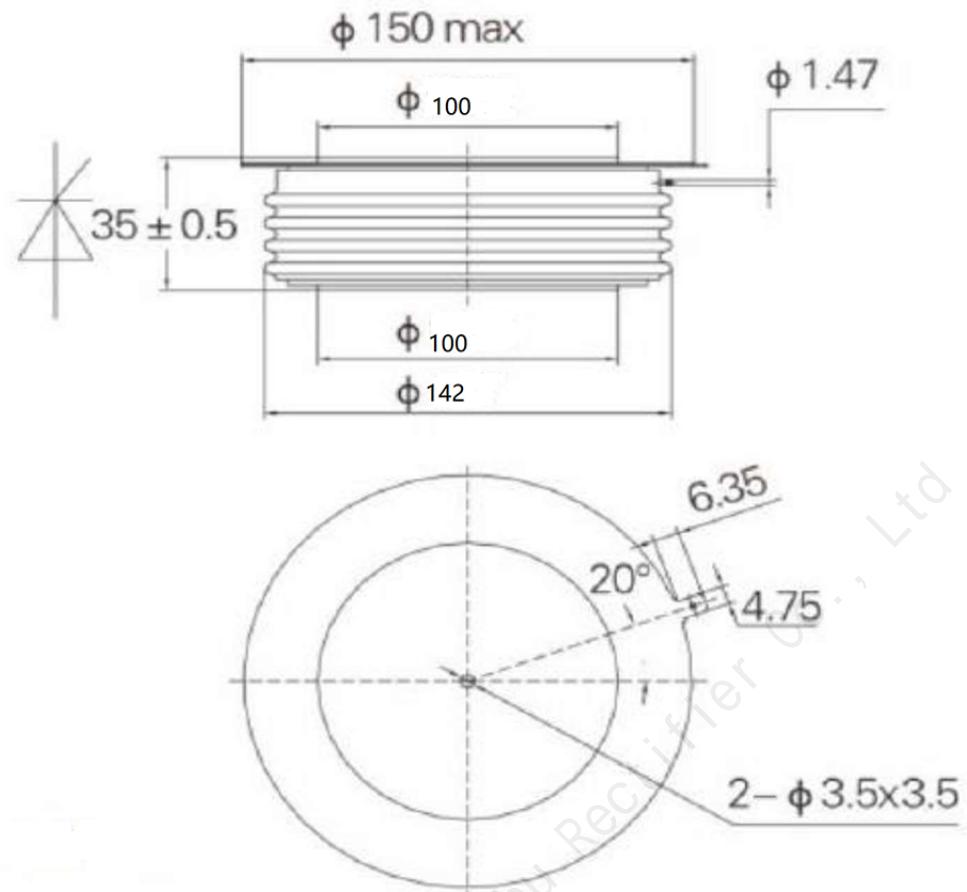
TRIGGERING				
I_{FGM}	Peak forward gate current	A	12	$T_j = T_{j \max}$
V_{RGM}	Peak reverse gate voltage	V	5	
P_G	Gate power dissipation	W	5	$T_j = T_{j \max}$ for DC gate current
SWITCHING				
$(di_T/dt)_{crit}$	Critical rate of rise of on-state current non-repetitive ($f=1$ Hz)	$A/\mu s$	1000	$T_j = T_{j \max}; V_D = 0.67 \cdot V_{DRM}; I_{TM} = 2 I_{TAV};$ Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu s; di_G/dt \geq 1 A/\mu s$
THERMAL				
T_{stg}	Storage temperature	$^{\circ}C$	-60 – 125	
T_j	Operating junction temperature	$^{\circ}C$	-60 – 125	
MECHANICAL				
F	Mounting force	kN	70.0 – 90.0	
a	Acceleration	m/s^2	50 100	Device unclamped Device clamped

CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions		
ON-STATE						
V_{TM}	Peak on-state voltage, max	V	2.20	$T_j = 25 ^{\circ}C; I_{TM} = 6300$ A		
$V_{T(TO)}$	On-state threshold voltage, max	V	1.00	$T_j = T_{j \max};$		
r_T	On-state slope resistance, max	$m\Omega$	0.170	$0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$		
I_L	Latching current, max	mA	1500	$T_j = 25 ^{\circ}C; V_D = 12$ V; Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu s; di_G/dt \geq 1 A/\mu s$		
I_H	Holding current, max	mA	300	$T_j = 25 ^{\circ}C;$ $V_D = 12$ V; Gate open		
BLOCKING						
I_{DRM}, I_{RRM}	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	300	$T_j = T_{j \max};$ $V_D = V_{DRM}; V_R = V_{RRM}$		
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage ¹⁾ , min	$V/\mu s$	1000	$T_j = T_{j \max};$ $V_D = 0.67 \cdot V_{DRM};$ Gate open		
TRIGGERING						
V_{GT}	Gate trigger direct voltage, max	V	3.00 2.00	$T_j = 25 ^{\circ}C$ $T_j = T_{j \max}$	$V_D = 12$ V; $I_D = 3$ A; Direct gate current	
I_{GT}	Gate trigger direct current, max	mA	300 200	$T_j = 25 ^{\circ}C$ $T_j = T_{j \max}$		
V_{GD}	Gate non-trigger direct voltage, min	V	0.35	$T_j = T_{j \max};$ $V_D = 0.67 \cdot V_{DRM};$ Direct gate current		
I_{GD}	Gate non-trigger direct current, min	mA	15.00			
SWITCHING						
t_{gd}	Delay time	μs	3.50	$T_j = 25 ^{\circ}C; V_D = 0.4 \cdot V_{DRM}; I_{TM} = 2000$ A; Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu s; di_G/dt \geq 1 A/\mu s$		
t_q	Turn-off time ²⁾ , max	μs	800	$dv_D/dt = 50 V/\mu s; T_j = T_{j \max}; I_{TM} = 2000$ A; $di_R/dt = -10 A/\mu s; V_R = 100$ V; $V_D = 0.67 \cdot V_{DRM};$		

THERMAL					
R_{thjc}	Thermal resistance, junction to case, max	$^{\circ}\text{C}/\text{W}$	0.0057	Direct current	Double side cooled
R_{thjc-A}			0.0125		Anode side cooled
R_{thjc-K}			0.0103		Cathode side cooled
R_{thck}	Thermal resistance, case to heatsink, max	$^{\circ}\text{C}/\text{W}$	0.0010	Direct current	
MECHANICAL					
W	Weight, typ	g	2700		
D_s	Surface creepage distance	mm (inch)	62.16 (2.447)		
D_a	Air strike distance	mm (inch)	26.00 (1.024)		

OVERALL DIMENSIONS



KT110DT

All dimensions in millimeters